



64K x 18 Synchronous Burst RAM Pipelined Output

Features

- Fast access times: 5, 6, 7, and 8 ns
- Fast clock speed: 100, 83, 66, and 50 MHz
- Provide high-performance 3-1-1-1 access rate
- Fast OE access times: 5 and 6 ns
- Optimal for performance (two cycle chip deselect, depth expansion without wait state)
- Single +3.3V –5 to +10% power supply
- 5V tolerant inputs except I/Os
- Clamp diodes to V_{SSQ} at all inputs and outputs
- Common data inputs and data outputs
- Byte Write Enable and Global Write control
- Three chip enables for depth expansion and address pipeline
- Address, control, input, and output pipeline registers
- Internally self-timed Write Cycle
- Write pass-through capability
- Burst control pins (interleaved or linear burst sequence)
- Automatic power-down for portable applications
- High-density, high-speed packages
- Low capacitive bus loading
- High 30-pF output drive capability at rated access time

Functional Description

The Cypress Synchronous Burst SRAM family employs high-speed, low-power CMOS designs using advanced double-layer polysilicon, double-layer metal technology. Each memory cell consists of four transistors and two high valued resistors.

Selection Guide

| | 7C1298A-100 7164C18-5 | 7C1298A-83 7164C18-6 | 7C1298A-66 7164C18-7 | 7C1298A-50 7164C18-8 |
|-----------------------------------|--------------------------|-------------------------|-------------------------|-------------------------|
| Maximum Access Time (ns) | 5 | 6 | 7 | 8 |
| Maximum Operating Current (mA) | 360 | 315 | 270 | 225 |
| Maximum CMOS Standby Current (mA) | 2 | 2 | 2 | 2 |

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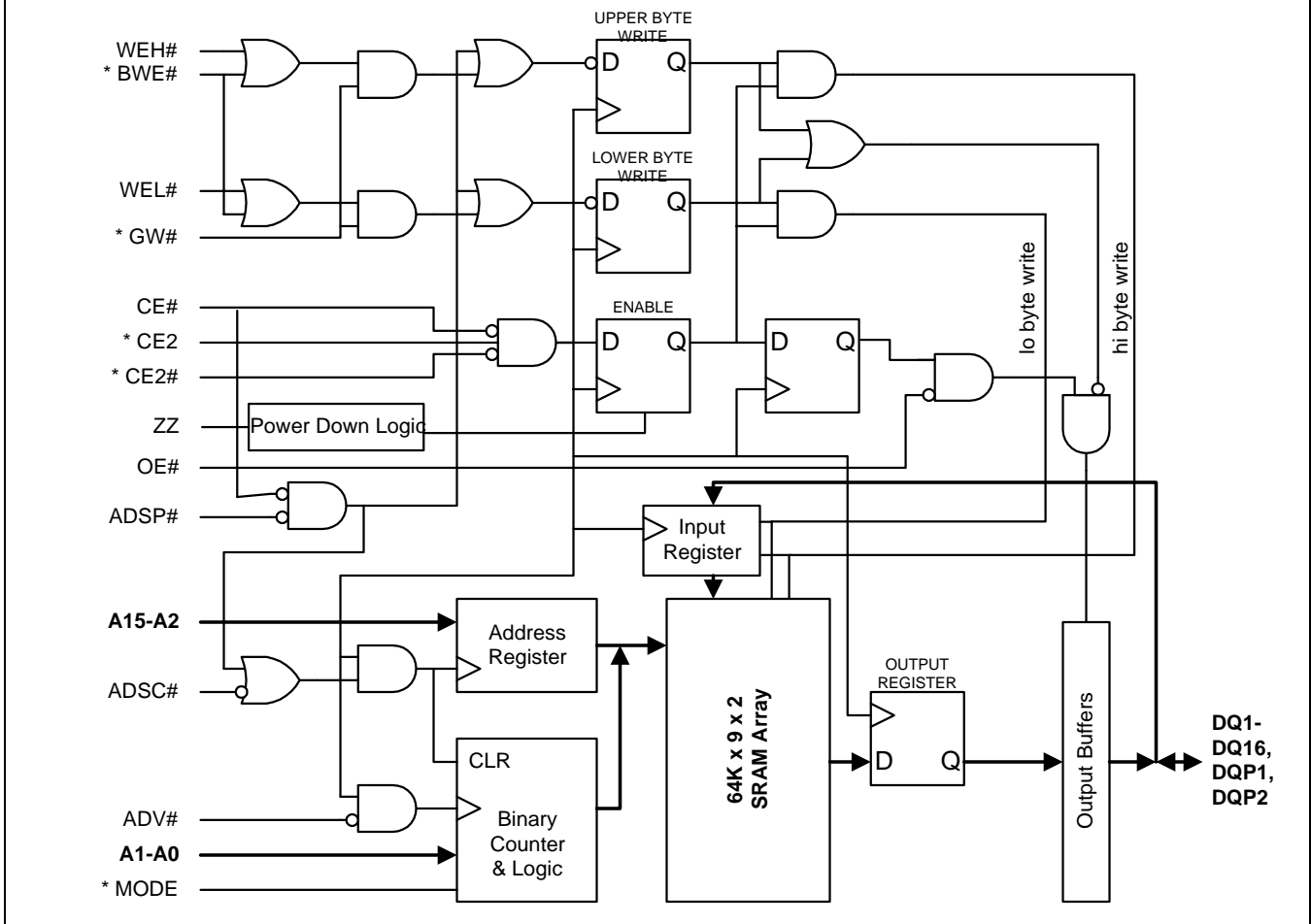
The CY7C1298A/GVT7164C18 SRAM integrates 65536x18 SRAM cells with advanced synchronous peripheral circuitry and a 2-bit counter for internal burst operation. All synchronous inputs are gated by registers controlled by a positive-edge-triggered Clock input (CLK). The synchronous inputs include all addresses, all data inputs, address-pipelining Chip Enable (CE), depth-expansion Chip Enables (CE2 and CE2), burst control inputs (ADSC, ADSP, and ADV), Write Enables (WEL, WEH, and BWE), and Global Write (GW).

Asynchronous inputs include the Output Enable (\overline{OE}) and Burst Mode Control (MODE). The data outputs (Q), enabled by OE, are also asynchronous.

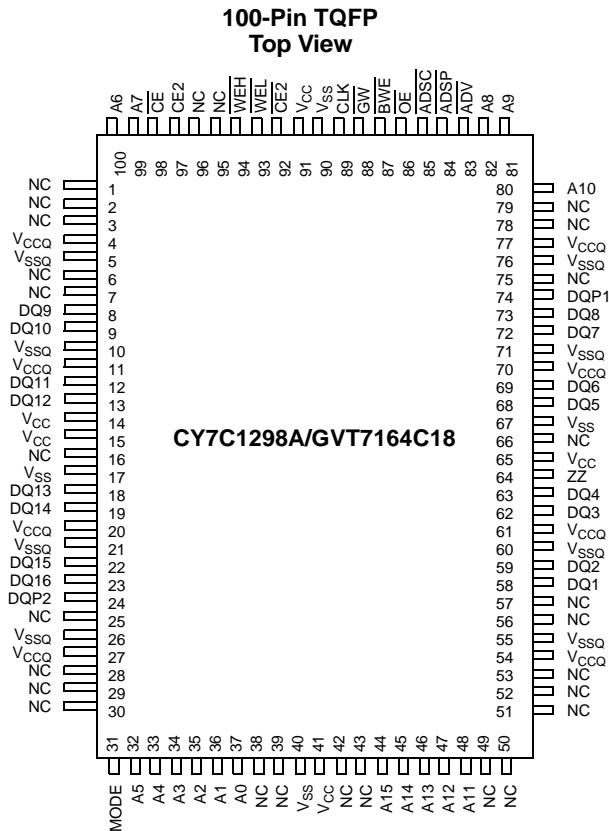
Addresses and chip enables are registered with either Address Status Processor (ADSP) or Address Status Controller (ADSC) input pins. Subsequent burst addresses can be internally generated as controlled by the burst advance pin (ADV).

Address, data inputs, and write controls are registered on-chip to initiate self-timed Write cycle. Write cycles can be one to four bytes wide as controlled by the write control inputs. Individual byte write allows individual byte to be written. WEL controls DQ1–DQ8 and DQP1. WEH controls DQ9–DQ16 and DQP2. WEL and WEH can be active only with BWE being LOW. GW being LOW causes all bytes to be written. This device also incorporates Write pass-through capability and pipelined enable circuit for better system performance.

The CY7C1298A/GVT7164C18 operates from a +3.3V power supply. All inputs and outputs are TTL-compatible. The device is ideally suited for 486, Pentium®, 680x0, and PowerPC™ systems and for systems that are benefited from a wide synchronous data bus.

Functional Block Diagram—64K x 18^[1]

Note:

1. The Functional Block Diagram illustrates simplified device operation. See Truth Table, pin descriptions and timing diagrams for detailed information.

Pin Configuration

Pin Descriptions

| QFP Pins | Pin Name | Type | Description |
|---|---|-------------------|---|
| 37, 36, 35, 34, 33, 32, 100, 99, 82, 81, 80, 48, 47, 46, 45, 44 | A0–A15 | Input-Synchronous | Addresses: These inputs are registered and must meet the set-up and hold times around the rising edge of CLK. The burst counter generates internal addresses associated with A0 and A1, during burst cycle and wait cycle. |
| 93, 94 | $\overline{\text{WEL}}$, $\overline{\text{WEH}}$ | Input-Synchronous | Byte Write Enables: A byte write enable is LOW for a Write cycle and HIGH for a Read cycle. $\overline{\text{WEL}}$ controls DQ1–DQ8 and DQP1. $\overline{\text{WEH}}$ controls DQ9–DQ16 and DQP2. Data I/O are high-impedance if either of these inputs are LOW, conditioned by BWE being LOW. |
| 87 | $\overline{\text{BWE}}$ | Input-Synchronous | Write Enable: This active LOW input gates byte write operations and must meet the set-up and hold times around the rising edge of CLK. |
| 88 | $\overline{\text{GW}}$ | Input-Synchronous | Global Write: This active LOW input allows a full 18-bit Write to occur independent of the BWE and WEn lines and must meet the set-up and hold times around the rising edge of CLK. |
| 89 | CLK | Input-Synchronous | Clock: This signal registers the addresses, data, chip enables, write control and burst control inputs on its rising edge. All synchronous inputs must meet set-up and hold times around the clock's rising edge. |
| 98 | $\overline{\text{CE}}$ | Input-Synchronous | Chip Enable: This active LOW input is used to enable the device and to gate ADSP. |
| 92 | $\overline{\text{CE2}}$ | Input-Synchronous | Chip Enable: This active LOW input is used to enable the device. |
| 97 | CE2 | Input-Synchronous | Chip Enable: This active HIGH input is used to enable the device. |

Pin Descriptions (continued)

| QFP Pins | Pin Name | Type | Description |
|--|-------------------|-------------------|--|
| 86 | \overline{OE} | Input | Output Enable: This active LOW asynchronous input enables the data output drivers. |
| 83 | \overline{ADV} | Input-Synchronous | Address Advance: This active LOW input is used to control the internal burst counter. A HIGH on this pin generates wait cycle (no address advance). |
| 84 | \overline{ADSP} | Input-Synchronous | Address Status Processor: This active LOW input, along with \overline{CE} being LOW, causes a new external address to be registered and a Read cycle is initiated using the new address. |
| 85 | \overline{ADSC} | Input-Synchronous | Address Status Controller: This active LOW input causes device to be de-selected or selected along with new external address to be registered. A Read or Write cycle is initiated depending upon write control inputs. |
| 31 | MODE | Input-Static | Mode: This input selects the burst sequence. A LOW on this pin selects Linear Burst. A NC or HIGH on this pin selects Interleaved Burst. |
| 64 | ZZ | Input-Static | Snooze: LOW or NC for normal operation. HIGH for low-power standby. |
| 58, 59, 62, 63, 68, 69, 72, 73, 8, 9, 12, 13, 18, 19, 22, 23 | DQ1–DQ16 | Input/Output | Data Inputs/Outputs: Low Byte is DQ1–DQ8. High Byte is DQ9–DQ16. Input data must meet set-up and hold times around the rising edge of CLK. |
| 74, 24 | DQP1, DQP2 | Input/Output | Parity Inputs/Outputs: DQP1 is parity bit for DQ1–DQ8 and DQP2 is parity bit for DQ9–DQ16. |
| 14, 15, 41, 65, 91 | V _{CC} | Supply | Power Supply: +3.3V –5% and +10%. |
| 17, 40, 67, 90 | V _{SS} | Ground | Ground: GND. |
| 4, 11, 20, 27, 54, 61, 70, 77 | V _{CCQ} | I/O Supply | Output Buffer Supply: +3.3V –5% and +10%. |
| 5, 10, 21, 26, 55, 60, 71, 76 | V _{SSQ} | I/O Ground | Output Buffer Ground: GND. |
| 1–3, 6, 7, 16, 25, 28–30, 38, 39, 42, 43, 49–53, 56, 57, 66, 75, 78–79, 95, 96 | NC | - | No Connect: These signals are not internally connected. |

Burst Address Table (MODE = NC/V_{CC})

| First Address (external) | Second Address (internal) | Third Address (internal) | Fourth Address (internal) |
|--------------------------|---------------------------|--------------------------|---------------------------|
| A...A00 | A...A01 | A...A10 | A...A11 |
| A...A01 | A...A00 | A...A11 | A...A10 |
| A...A10 | A...A11 | A...A00 | A...A01 |
| A...A11 | A...A10 | A...A01 | A...A00 |

Burst Address Table (MODE = GND)

| First Address (external) | Second Address (internal) | Third Address (internal) | Fourth Address (internal) |
|--------------------------|---------------------------|--------------------------|---------------------------|
| A...A00 | A...A01 | A...A10 | A...A11 |
| A...A01 | A...A10 | A...A11 | A...A00 |
| A...A10 | A...A11 | A...A00 | A...A01 |
| A...A11 | A...A00 | A...A01 | A...A10 |

Partial Truth Table for Read/Write

| Function | \overline{GW} | \overline{BWE} | \overline{WEH} | \overline{WEL} |
|-----------------|-----------------|------------------|------------------|------------------|
| READ | H | H | X | X |
| READ | H | L | H | H |
| WRITE one byte | H | L | L | H |
| WRITE all bytes | H | L | L | L |
| WRITE all bytes | L | X | X | X |

Truth Table^[2, 3, 4, 5, 6, 7, 8]

| Operation | Address Used | \overline{CE} | $\overline{CE2}$ | CE2 | \overline{ADSP} | \overline{ADSC} | \overline{ADV} | \overline{WRITE} | \overline{OE} | CLK | DQ |
|------------------------------|--------------|-----------------|------------------|-----|-------------------|-------------------|------------------|--------------------|-----------------|-----|--------|
| Deselected Cycle, Power Down | None | H | X | X | X | L | X | X | X | L-H | High-Z |
| Deselected Cycle, Power Down | None | L | X | L | L | X | X | X | X | L-H | High-Z |
| Deselected Cycle, Power Down | None | L | H | X | L | X | X | X | X | L-H | High-Z |
| Deselected Cycle, Power Down | None | L | X | L | H | L | X | X | X | L-H | High-Z |
| Deselected Cycle, Power Down | None | L | H | X | H | L | X | X | X | L-H | High-Z |
| READ Cycle, Begin Burst | External | L | L | H | L | X | X | X | L | L-H | Q |
| READ Cycle, Begin Burst | External | L | L | H | L | X | X | X | H | L-H | High-Z |
| WRITE Cycle, Begin Burst | External | L | L | H | H | L | X | L | X | L-H | D |
| READ Cycle, Begin Burst | External | L | L | H | H | L | X | H | L | L-H | Q |
| READ Cycle, Begin Burst | External | L | L | H | H | L | X | H | H | L-H | High-Z |
| READ Cycle, Continue Burst | Next | X | X | X | H | H | L | H | L | L-H | Q |
| READ Cycle, Continue Burst | Next | X | X | X | H | H | L | H | H | L-H | High-Z |
| READ Cycle, Continue Burst | Next | H | X | X | X | H | L | H | L | L-H | Q |
| READ Cycle, Continue Burst | Next | H | X | X | X | H | L | H | H | L-H | High-Z |
| WRITE Cycle, Continue Burst | Next | X | X | X | H | H | L | L | X | L-H | D |
| WRITE Cycle, Continue Burst | Next | H | X | X | X | H | L | L | X | L-H | D |
| READ Cycle, Suspend Burst | Current | X | X | X | H | H | H | H | L | L-H | Q |
| READ Cycle, Suspend Burst | Current | X | X | X | H | H | H | H | H | L-H | High-Z |
| READ Cycle, Suspend Burst | Current | H | X | X | X | H | H | H | L | L-H | Q |
| READ Cycle, Suspend Burst | Current | H | X | X | X | H | H | H | H | L-H | High-Z |
| WRITE Cycle, Suspend Burst | Current | X | X | X | H | H | H | L | X | L-H | D |
| WRITE Cycle, Suspend Burst | Current | H | X | X | X | H | H | L | X | L-H | D |

Pass-Through Truth Table

| Previous Cycle ^[9] | | Present Cycle | | | | Next Cycle |
|--|---------------------------|--|----|-----|----|-----------------------------------|
| Operation | BWn | Operation | CE | BWn | OE | Operation |
| Initiate WRITE cycle, all bytes Address = A(n-1), data = D(n-1) | All L ^[10, 11] | Initiate READ cycle Register A(n), Q = D(n-1) | L | H | L | Read D(n) |
| Initiate WRITE cycle, all bytes Address = A(n-1), data = D(n-1) | All L ^[10, 11] | No new cycle Q = D(n-1) | H | H | L | No carry-over from previous cycle |
| Initiate WRITE cycle, all bytes Address = A(n-1), data = D(n-1) | All L ^[10, 11] | No new cycle Q = High-Z | H | H | H | No carry-over from previous cycle |
| Initiate WRITE cycle, one byte Address = A(n-1), data = D(n-1) | One L ^[10] | No new cycle Q = D(n-1) for one byte | H | H | L | No carry-over from previous cycle |

Notes:

- X means "don't care." H means logic HIGH. L means logic LOW. $\overline{WRITE} = L$ means $[\overline{BWE} + \overline{WEL} * \overline{WEH}] * \overline{GW}$ equals LOW. $\overline{WRITE} = H$ means $[\overline{BWE} + \overline{WEL} * \overline{WEH}] * \overline{GW}$ equals HIGH.
- WEL enables write to DQ1-DQ8 and DQP1. WEH enables write to DQ9-DQ16 and DQP2.
- All inputs except OE must meet set-up and hold times around the rising edge (LOW to HIGH) of CLK.
- Suspending burst generates wait cycle.
- For a write operation following a read operation, \overline{OE} must be HIGH before the input data required set-up time plus High-Z time for \overline{OE} and staying HIGH throughout the input data hold time.
- This device contains circuitry that will ensure the outputs will be in High-Z during power-up.
- ADSP LOW along with chip being selected always initiates a READ cycle at the L-H edge of CLK. A WRITE cycle can be performed by setting \overline{WRITE} LOW for the CLK L-H edge of the subsequent wait cycle. Refer to Write timing diagram for clarification.
- Previous cycle may be any cycle (non-burst, burst, or wait).
- \overline{BWE} is LOW for individual byte WRITE.
- GW LOW yields the same result for all-byte WRITE operation.

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Voltage on V_{CC} Supply Relative to V_{SS} -0.5V to +4.6V
 V_{IN} -0.5V to 6V
 Storage Temperature (plastic) -55°C to +150°C
 Junction Temperature +150°C

Power Dissipation..... 1.6W
 Short Circuit Output Current..... 100 mA

Operating Range

| Range | Ambient Temperature ^[12] | V_{CC} |
|-------|-------------------------------------|---------------|
| Com'l | 0°C to +70°C | 3.3V -5%/+10% |

Electrical Characteristics Over the Operating Range

| Parameter | Description | Test Conditions | Min. | Max. | Unit |
|-----------|--|---|------|-----------------|---------|
| V_{IH} | Input High (Logic 1) Voltage ^[13, 14] | | 2.0 | $V_{CCQ} + 0.3$ | V |
| V_{IL} | Input Low (Logic 0) Voltage ^[13, 14] | | -0.3 | 0.8 | V |
| I_{LI} | Input Leakage Current ^[15] | $0V \leq V_{IN} \leq V_{CC}$ | -2 | 2 | μA |
| I_{LO} | Output Leakage Current | Output(s) disabled, $0V \leq V_{OUT} \leq V_{CC}$ | -2 | 2 | μA |
| V_{OH} | Output High Voltage ^[13, 16] | $I_{OH} = -4.0$ mA | 2.4 | | V |
| V_{OL} | Output Low Voltage ^[13, 16] | $I_{OL} = 8.0$ mA | | 0.4 | V |
| V_{CC} | Supply Voltage ^[13] | | 3.1 | 3.6 | V |

| Parameter | Description | Conditions | Typ. | 100 MHz -5 | 83 MHz -6 | 66 MHz -7 | 50 MHz -8 | Unit |
|-----------|---|--|------|------------|-----------|-----------|-----------|------|
| I_{CC} | Power Supply Current: Operating ^[17, 18, 19] | Device selected; all inputs $\leq V_{IL}$ or $\geq V_{IH}$; cycle time $\geq t_{KC}$ min.; $V_{CC} = \text{Max.}$; outputs open | 180 | 360 | 315 | 270 | 225 | mA |
| I_{SB1} | Power Supply Current: Idle ^[18, 19] | Device selected; ADSC, ADSP, ADV, GW, BWE $\geq V_{IH}$; all other inputs $\leq V_{IL}$ or $\geq V_{IH}$; $V_{CC} = \text{Max.}$; cycle time $\geq t_{KC}$ min.; outputs open | 30 | 60 | 55 | 50 | 45 | mA |
| I_{SB2} | CMOS Standby ^[18, 19] | Device deselected; $V_{CC} = \text{Max.}$; all inputs $\leq V_{SS} + 0.2$ or $\geq V_{CC} - 0.2$; all inputs static; CLK frequency = 0 | 0.2 | 2 | 2 | 2 | 2 | mA |
| I_{SB3} | TTL Standby ^[18, 19] | Device deselected; all inputs $\leq V_{IL}$ or $\geq V_{IH}$; all inputs static; $V_{CC} = \text{Max.}$; CLK frequency = 0 | 8 | 18 | 18 | 18 | 18 | mA |
| I_{SB4} | Clock Running ^[18, 19] | Device deselected; all inputs $\leq V_{IL}$ or $\geq V_{IH}$; $V_{CC} = \text{Max.}$; CLK cycle time $\geq t_{KC}$ min. | 30 | 60 | 55 | 50 | 45 | mA |

Capacitance^[20]

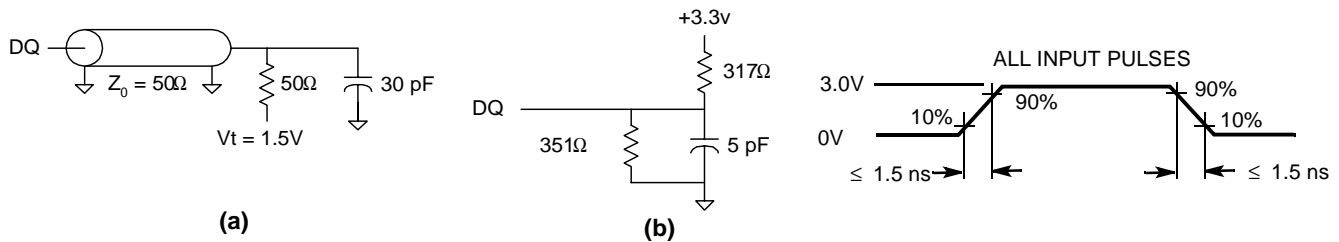
| Parameter | Description | Test Conditions | Typ. | Max. | Unit |
|-----------|-------------------------------|--|------|------|------|
| C_I | Input Capacitance | $T_A = 25^\circ C$, $f = 1$ MHz, $V_{CC} = 3.3V$ | 3 | 4 | pF |
| C_O | Input/Output Capacitance (DQ) | | 6 | 7 | pF |

Notes:

12. T_A is the case temperature.
13. All voltages referenced to V_{SS} (GND).
14. Overshoot: $V_{IH} \leq +6.0V$ for $t \leq t_{KC} / 2$.
Undershoot: $V_{IL} \leq -2.0V$ for $t \leq t_{KC} / 2$
15. MODE pin has an internal pull-up and ZZ pin has an internal pull-down. These two pins exhibit an input leakage current of $\pm 30 \mu A$.
16. AC I/O curves are available upon request.
17. I_{CC} is given with no output current. I_{CC} increases with greater output loading and faster cycle times.
18. "Device Deselected" means the device is in Power-Down mode as defined in the truth table. "Device Selected" means the device is active.
19. Typical values are measured at 3.3V, 25°C, and 20-ns cycle time.
20. This parameter is sampled.

Thermal Resistance

| Description | Test Conditions | Symbol | TQFP Typ. | Unit |
|--|---|---------------|-----------|------|
| Thermal Resistance (Junction to Ambient) | Still Air, soldered on a 4.25 x 1.125 inch, 4-layer PCB | Θ_{JA} | 20 | °C/W |
| Thermal Resistance (Junction to Case) | | Θ_{JC} | 1 | °C/W |

AC Test Loads and Waveforms

Capacitance Derating^[21]

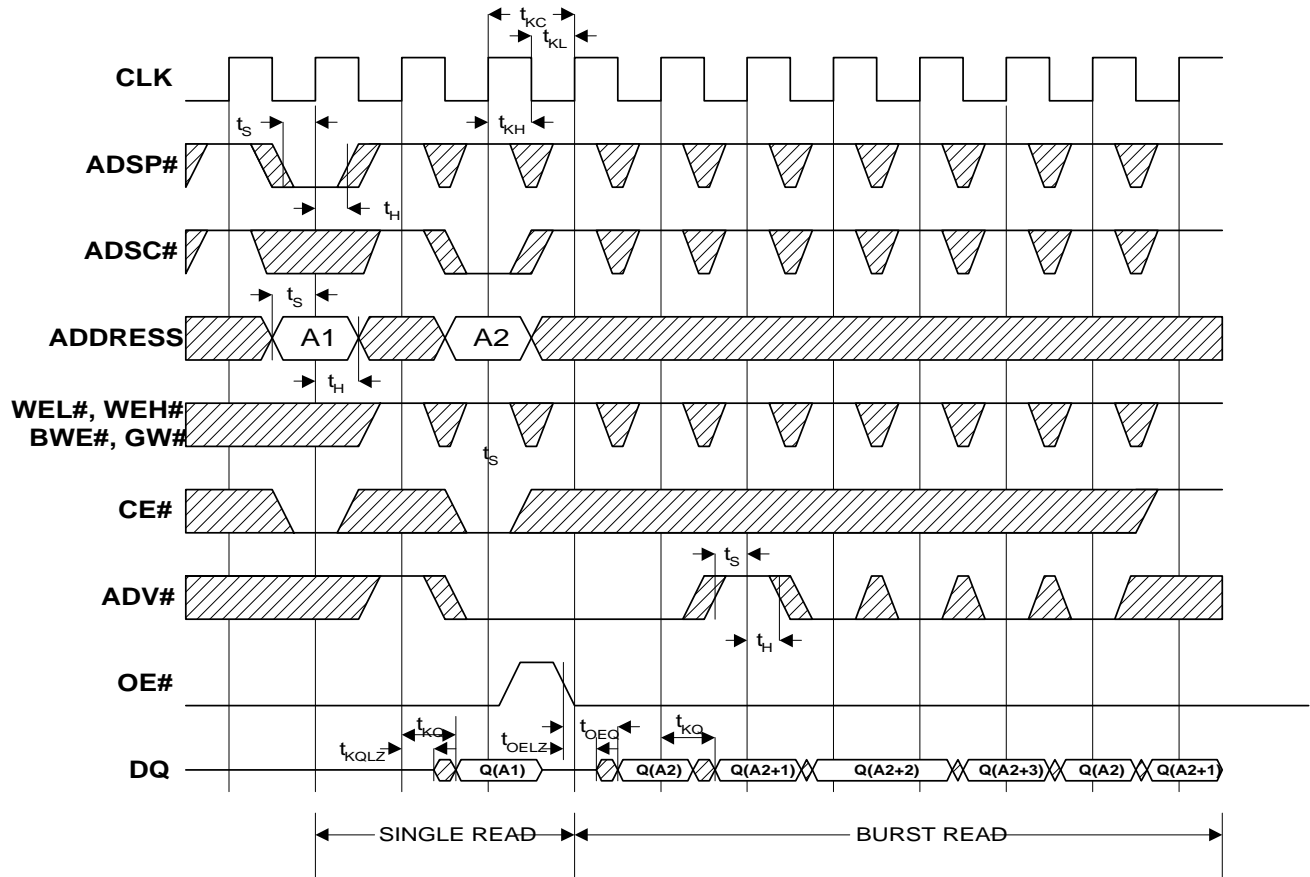
| Description | Symbol | Typ. | Max. | Unit |
|-----------------------|-----------------|-------|------|---------|
| Clock to output valid | Δt_{KQ} | 0.016 | | ns / pF |

Switching Characteristics Over the Operating Range^[22]

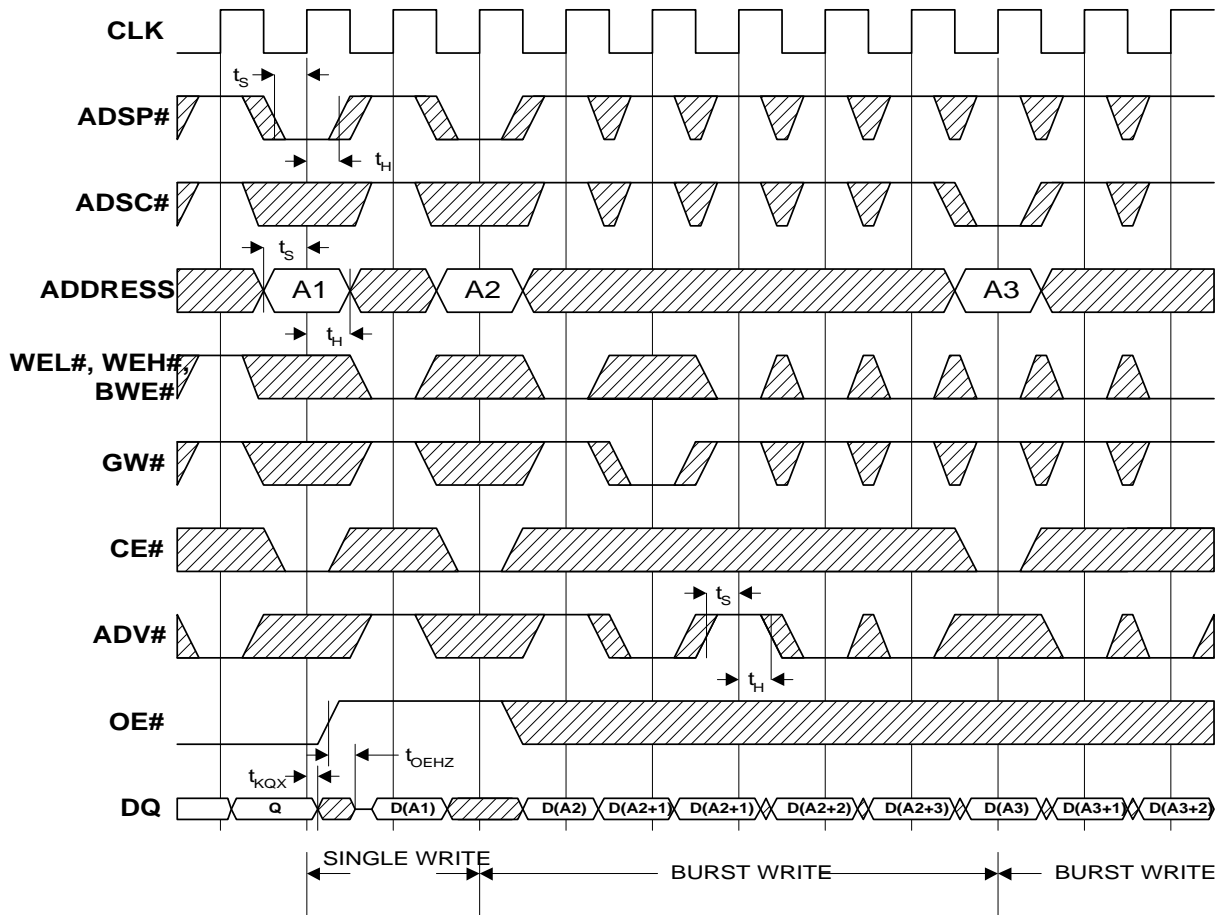
| Parameter | Description | 100 MHz -5 | | 83 MHz -6 | | 66 MHz -7 | | 50 MHz -8 | | Unit |
|---------------------|--|---------------|------|--------------|------|--------------|------|--------------|------|------|
| | | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | |
| Clock | | | | | | | | | | |
| t_{KC} | Clock Cycle Time | 10 | | 12 | | 15 | | 20 | | ns |
| t_{KH} | Clock HIGH Time | 4 | | 4 | | 5 | | 6 | | ns |
| t_{KL} | Clock LOW Time | 4 | | 4 | | 5 | | 6 | | ns |
| Output Times | | | | | | | | | | |
| t_{KQ} | Clock to Output Valid | | 5 | | 6 | | 7 | | 8 | ns |
| t_{KQX} | Clock to Output Invalid | 2 | | 2 | | 2 | | 2 | | ns |
| t_{KQLZ} | Clock to Output in Low-Z ^[23, 24] | 3 | | 3 | | 3 | | 3 | | ns |
| t_{KQHZ} | Clock to Output in High-Z ^[23, 24] | | 5 | | 5 | | 6 | | 6 | ns |
| t_{OEQ} | OE to Output Valid ^[25] | | 5 | | 5 | | 5 | | 6 | ns |
| t_{OELZ} | OE to Output in Low-Z ^[23, 24] | 0 | | 0 | | 0 | | 0 | | ns |
| t_{OEHZ} | OE to Output in High-Z ^[23, 24] | | 4 | | 5 | | 6 | | 6 | ns |
| Set-up Times | | | | | | | | | | |
| t_S | Address, Controls, and Data In ^[26] | 2.5 | | 2.5 | | 2.5 | | 3 | | ns |
| Hold Times | | | | | | | | | | |
| t_H | Address, Controls, and Data In ^[26] | 0.5 | | 0.5 | | 0.5 | | 0.5 | | ns |

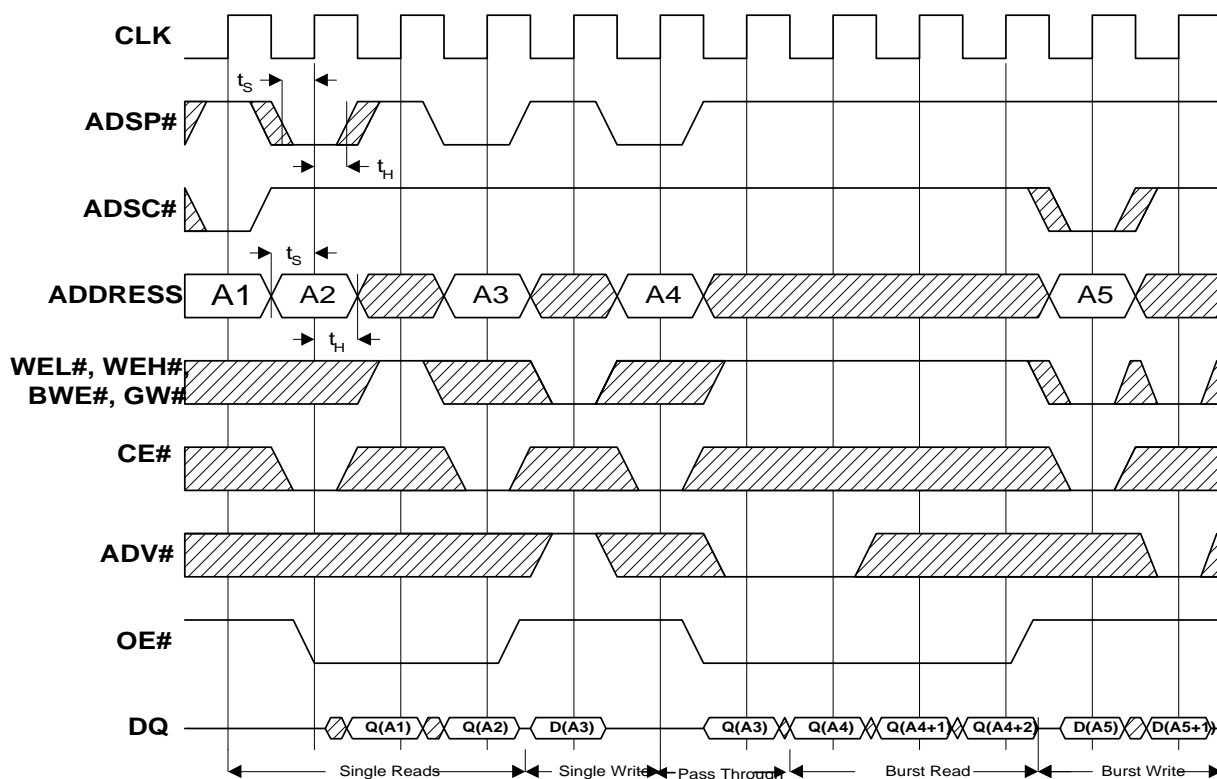
Notes:

21. Capacitance derating applies to capacitance different from the load capacitance shown in part (a) of AC Test Loads.
22. Test conditions as specified with the output loading as shown in part (a) of AC Test Loads unless otherwise noted.
23. Output loading is specified with $C_L = 5$ pF as in AC Test Loads.
24. At any given temperature and voltage condition, t_{KQHZ} is less than t_{KQLZ} and t_{OEHZ} is less than t_{OELZ} .
25. OE is a "don't care" when a byte write enable is sampled LOW.
26. This is a synchronous device. All synchronous inputs must meet specified set-up and hold time, except for "don't care" as defined in the truth table.

Timing Diagrams
Read Timing^[27]

Notes:

27. \overline{CE} active in this timing diagram means that all chip enables \overline{CE} , CE2, and $\overline{CE2}$ are active.

Timing Diagrams (continued)
Write Timing^[27]


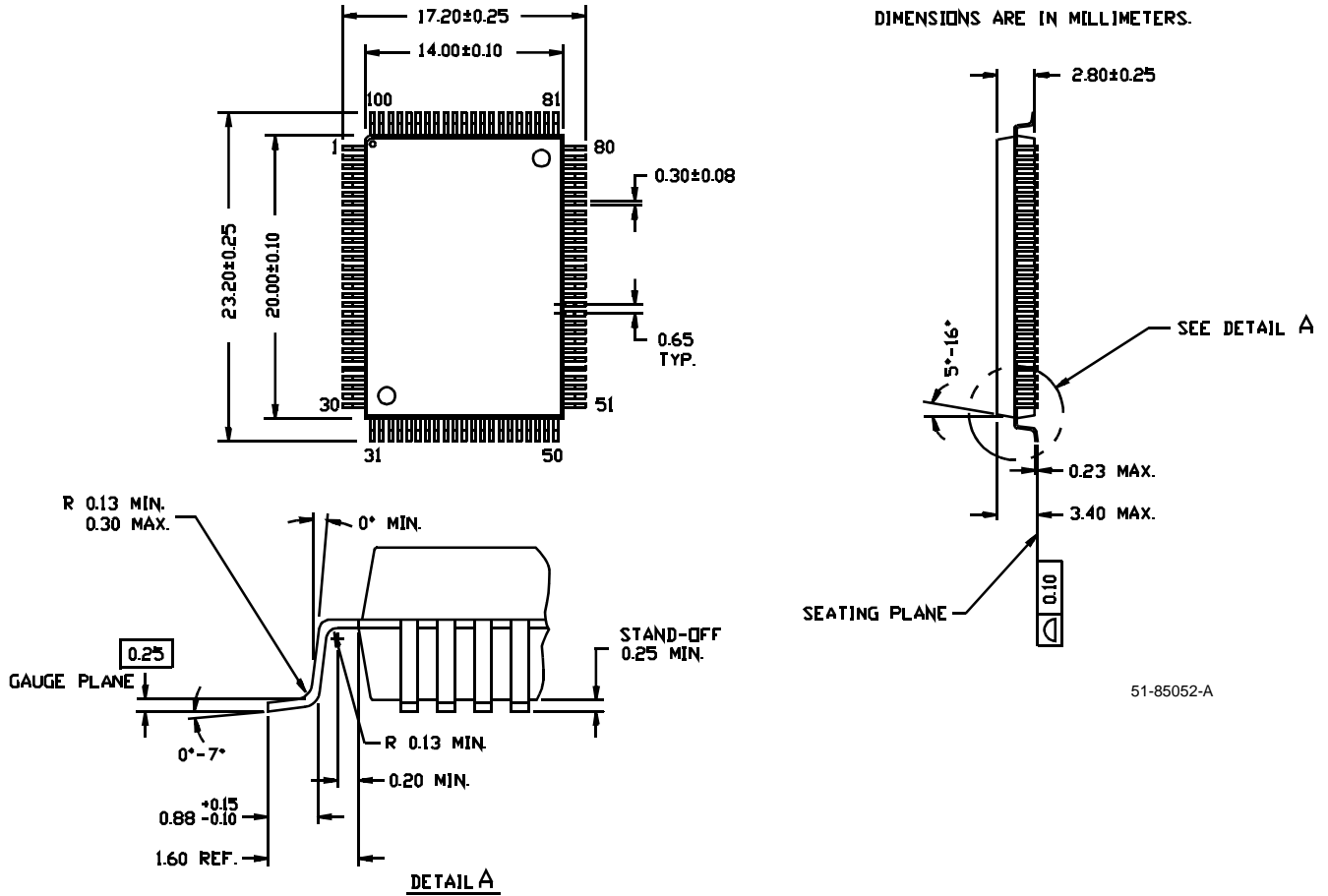
Timing Diagrams (continued)
Read/Write Timing^[27]

Ordering Information

| Speed (MHz) | Ordering Code | Package Name | Package Type | Operating Range |
|-------------|-----------------------------------|--------------|--------------------------------|-----------------|
| 100 | CY7C1298A-100NC/ GVT7164C18Q-5 | N100 | 100-Lead Plastic Quad Flatpack | Commercial |
| 83 | CY7C1298A-83NC/ GVT7164C18Q-6 | N100 | 100-Lead Plastic Quad Flatpack | Commercial |
| 66 | CY7C1298A-66NC/ GVT7164C18Q-7 | N100 | 100-Lead Plastic Quad Flatpack | Commercial |
| 50 | CY7C1298A-50NC/ GVT7164C18Q-8 | N100 | 100-Lead Plastic Quad Flatpack | Commercial |



Package Diagram

100-Lead Plastic Quad Flatpack N100



51-85052-A

Revision History

| Document Title: CY7C1298A/GVT7164C18 64K x 18 Synchronous Burst RAM Pipelined Output Document Number: 38-05194 | | | | |
|---|----------------|-------------------|------------------------|---|
| REV. | ECN NO. | Issue Date | Orig. of Change | Description of Change |
| ** | 111323 | 02/22/02 | CJM | Converted from Galvantech format Change CY part number from CY7C1315A to CY7C1298A |